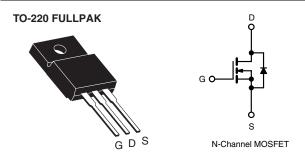


Vishay Siliconix

### **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	100			
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V	0.54		
Q <sub>g</sub> (Max.) (nC)	8.3			
Q <sub>gs</sub> (nC)	2.3			
Q <sub>gd</sub> (nC)	3.8			
Configuration	Single			



### **FEATURES**

- · Isolated Package
- High Voltage Isolation = 2.5 kV<sub>RMS</sub> (t = 60 s; f = 60 Hz)



- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- Dynamic dV/dt Rating
- Low Thermal Resistance
- · Lead (Pb)-free Available

#### **DESCRIPTION**

Third Generation Power MOSFETs from Vishay provides the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION		
Package	TO-220 FULLPAK	
Lead (Pb)-free	IRFI510GPbF	
Lead (1 b)-nee	SiHFI510G-E3	
SnPb	IRFI510G	
	SiHFI510G	

<b>ABSOLUTE MAXIMUM RATINGS</b> $T_C = 25$ °C, unless otherwise noted					
PARAMETER	SYMBOL	LIMIT	UNIT		
Gate-Source Voltage		$V_{GS}$	± 20	V	
Continuous Drain Current	$V_{GS}$ at 10 V $T_{C} = 25 ^{\circ}C$ $T_{C} = 100 ^{\circ}C$	1_	4.5	А	
	$T_C = 100 ^{\circ}$ C	I <sub>D</sub>	3.2		
Pulsed Drain Current <sup>a</sup>	I <sub>DM</sub>	18	1		
Linear Derating Factor			0.18	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>		E <sub>AS</sub>	60	mJ	
Repetitive Avalanche Currenta		I <sub>AR</sub>	4.5	Α	
Repetitive Avalanche Energy <sup>a</sup>		E <sub>AR</sub>	2.7	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C	$P_{D}$	27	W	
Peak Diode Recovery dV/dtc		dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range		$T_J,T_stg$	- 55 to + 175	- °C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>	7	
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
	0-32 OF IVIS SCIEW		1.1	N · m	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 25 V, starting  $T_J$  = 25 °C, L = 4.4 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AS}$  = 4.5 A (see fig. 12).
- c.  $I_{SD} \leq 5.6$  A,  $dI/dt \leq 75$  A/µs,  $V_{DD} \leq V_{DS}, \, T_J \leq 175$  °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFI510G, SiHFI510G

# Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	=	5.5	C/VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							•
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		100	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I <sub>D</sub> = 1 mA		-	0.63	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA		2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ± 20		-	-	± 100	nA
Zero Gate Voltage Drain Current	l	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V		-	-	25	μΑ
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 80 V, V	V <sub>DS</sub> = 80 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C		-	250	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 2.7 A <sup>b</sup>	-	-	0.54	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 2.7 A <sup>b</sup>		1.2	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V		-	180	-	pF
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 25 V		ı	81	-	
Reverse Transfer Capacitance	$C_{rss}$	f = 1.0 MHz, see fig. 5		ī	15	-	
Drain to Sink Capacitance	С	f =	f = 1.0 MHz		12	-	
Total Gate Charge	$Q_g$				-	8.3	
Gate-Source Charge	$Q_{gs}$	V <sub>GS</sub> = 10 V	$I_D = 5.6 \text{ A}, V_{DS} = 80 \text{ V},$ see fig. 6 and 13 <sup>b</sup>	-	-	2.3	nC
Gate-Drain Charge	$Q_{gd}$		see lig. 6 and 15	-	-	3.8	
Turn-On Delay Time	t <sub>d(on)</sub>			-	6.9	-	
Rise Time	t <sub>r</sub>	$V_{DD} = 50 \text{ V}, I_D = 5.6 \text{ A}$ $R_G = 24 \ \Omega, R_D = 8.4 \ \Omega, \text{ see fig. } 10^b$		-	16	-	- ns
Turn-Off Delay Time	t <sub>d(off)</sub>			-	15	-	
Fall Time	t <sub>f</sub>			ı	9.4	-	
Internal Drain Inductance	$L_D$	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	ml l
Internal Source Inductance	L <sub>S</sub>			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s				•	•	,
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	4.5	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	18	A
Body Diode Voltage	$V_{SD}$	$T_J = 25  ^{\circ}\text{C}, \ I_S = 4.5  \text{A}, \ V_{GS} = 0  \text{V}^{\text{b}}$		-	-	2.5	٧
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25 ^{\circ}\text{C}, I_F = 5.6 \text{A},  \text{di/dt} = 100 \text{A/}\mu\text{s}^{\text{b}}$		ı	100	200	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.44	0.88	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-	on is dor	ninated b	y L <sub>S</sub> and	 L <sub>D</sub> )	

### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

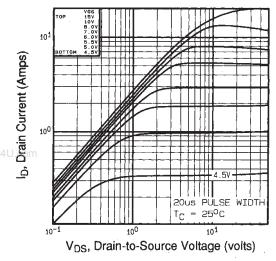


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

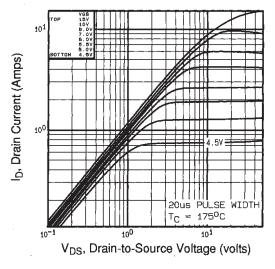


Fig. 2 - Typical Output Characteristics,  $T_C = 175$  °C

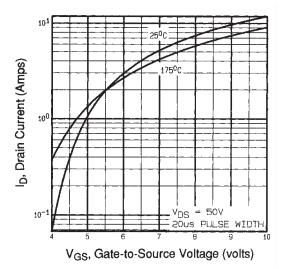


Fig. 3 - Typical Transfer Characteristics

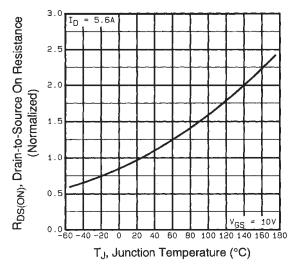


Fig. 4 - Normalized On-Resistance vs. Temperature

## IRFI510G, SiHFI510G

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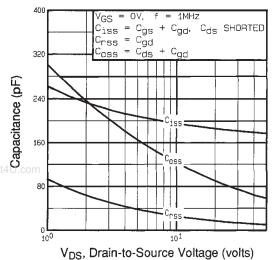


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

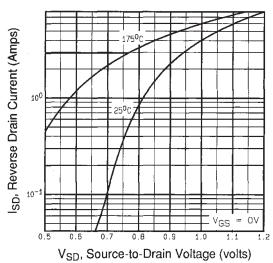


Fig. 7 - Typical Source-Drain Diode Forward Voltage

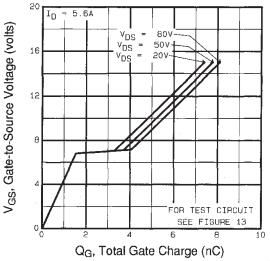


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

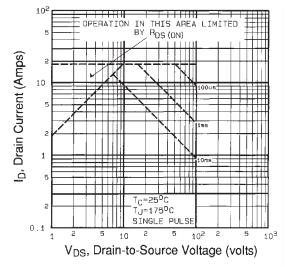


Fig. 8 - Maximum Safe Operating Area





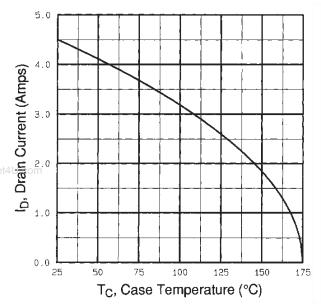


Fig. 9 - Maximum Drain Current vs. Case Temperature

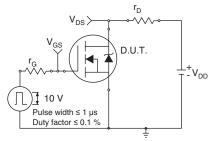


Fig. 10a - Switching Time Test Circuit

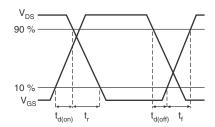


Fig. 10b - Switching Time Waveforms

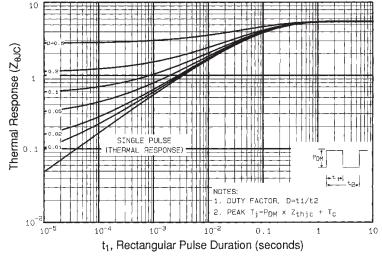


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

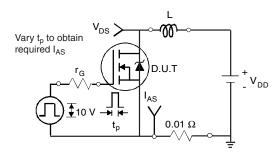


Fig. 12a - Unclamped Inductive Test Circuit

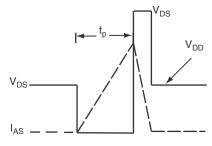


Fig. 12b - Unclamped Inductive Waveforms

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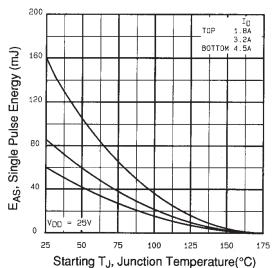


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

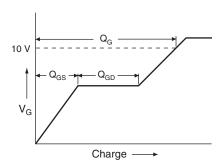


Fig. 13a - Basic Gate Charge Waveform

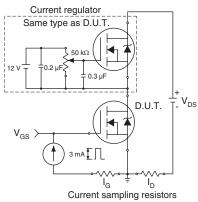
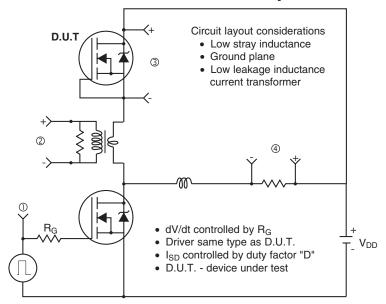


Fig. 13b - Gate Charge Test Circuit



## Peak Diode Recovery dV/dt Test Circuit



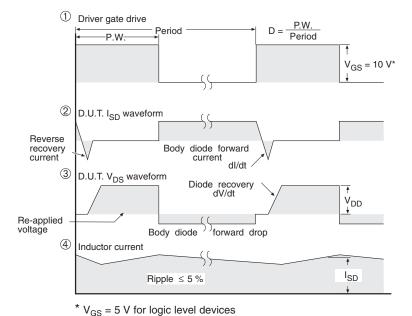


Fig. 14 - For N-Channel

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Document Number: 90178 S-Pending-Rev. A, 16-Jun-08





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